Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/665,101	CHANG, KEN K.	
Examiner	Art Unit	

1714

Kriellion A. Sanders

SEARCHED				
Class	Subclass	Date	Examiner	
523	144			
524	503			
524	557			
524	596			
524	612	4/27/2006	KS	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
523	144			
524	503, 557			
524	596, 612	4/27/2006	KS	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
WEST			
Inventors Name Search	4/27/2006	KS	
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